imall

Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from, Europe, America and south Asia, supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

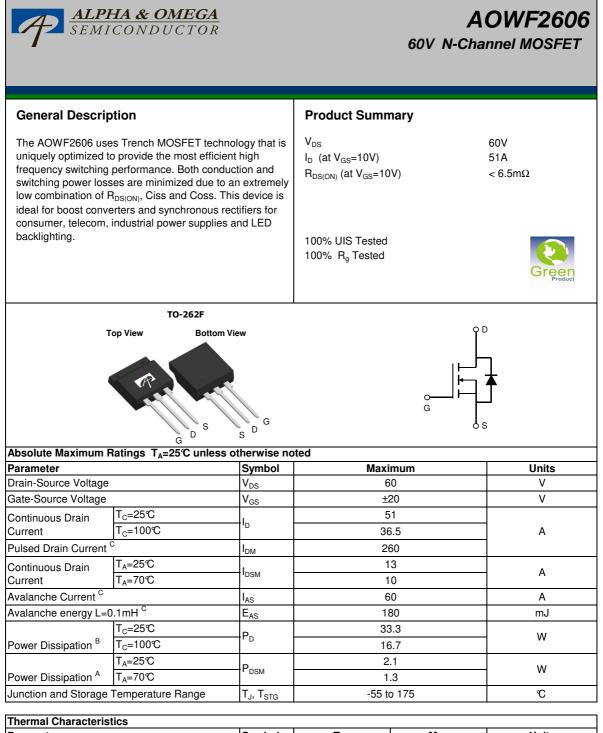
We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



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Tel: +86-755-8981 8866 Fax: +86-755-8427 6832 Email & Skype: info@chipsmall.com Web: www.chipsmall.com Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China





Parameter		Symbol	Тур	Max	Units				
Maximum Junction-to-Ambient A	t ≤10s	R _{eJA}	11	15	°C/W				
Maximum Junction-to-Ambient AD	Steady-State	Π _θ JA	47	60	°C/W				
Maximum Junction-to-Case	Steady-State	$R_{\theta JC}$	3.7	4.5	°C/W				



Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Parameter Conditions		Min	Тур	Max	Units
STATIC P	PARAMETERS						
BV _{DSS}	Drain-Source Breakdown Voltage	I _D =250μA, V _{GS} =0V		60			V
I _{DSS} Zero Gat	Zero Gate Voltage Drain Current	V _{DS} =60V, V _{GS} =0V				1	μA
	Zero date voltage Drain ourrent		T_=55℃			5	μΑ
I _{GSS}	Gate-Body leakage current	$V_{DS}=0V, V_{GS}=\pm 20V$				±100	nA
V _{GS(th)}	Gate Threshold Voltage	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$		2.5	3	3.5	V
I _{D(ON)}	On state drain current	V_{GS} =10V, V_{DS} =5V		260			А
R _{DS(ON)} S	Static Drain-Source On-Resistance	V _{GS} =10V, I _D =20A			5.4	6.5	mΩ
	Static Drain-Source On-Hesistance		T_=125℃		8.5	10.5	11152
g _{FS}	Forward Transconductance	V_{DS} =5V, I_{D} =20A			75		S
V _{SD}	Diode Forward Voltage	I _S =1A,V _{GS} =0V			0.7	1	V
ls	Maximum Body-Diode Continuous Current					35	Α
DYNAMIC	PARAMETERS						
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =30V, f=1MHz			4050		pF
C _{oss}	Output Capacitance				345		pF
C _{rss}	Reverse Transfer Capacitance				16.8		pF
R _g	Gate resistance	$V_{GS}=0V, V_{DS}=0V, f=1MHz$		0.3	0.65	1.0	Ω
SWITCHI	NG PARAMETERS						
Q _g (10V)	Total Gate Charge				53	75	nC
Q _g (4.5V)	Total Gate Charge	V _{GS} =10V, V _{DS} =30V, I _D	-204		22	31	nC
Q _{gs}	Gate Source Charge	$V_{GS} = 100, V_{DS} = 300, I_D = 20A$			17		nC
Q_{gd}	Gate Drain Charge				5		nC
t _{D(on)}	Turn-On DelayTime	V_{GS} =10V, V_{DS} =30V, R_L =1.5 Ω , R_{GEN} =3 Ω			18		ns
t _r	Turn-On Rise Time				20		ns
t _{D(off)}	Turn-Off DelayTime				33		ns
t _f	Turn-Off Fall Time				4		ns
t _{rr}	Body Diode Reverse Recovery Time	I _F =20A, dl/dt=500A/μs			26		ns
Q _{rr}	Body Diode Reverse Recovery Charge	e I _F =20A, dl/dt=500A/μs		125		nC	

A. The value of $R_{\theta,JA}$ is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with $T_A = 25^{\circ}$ C. The Power dissipation P_{DSM} is based on R _{eJA} and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design, and the maximum temperature of 175° C may be used if the PCB allows it.

B. The power dissipation P_D is based on T_{J(MAX)}=175° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature T_{J(MAX)}=175° C. Ratings are based on low frequency and duty cycles to keep initial T_{.1}=25° C.

 $\vec{D.}$ The $R_{_{\theta JA}}$ is the sum of the thermal impedance from junction to case $R_{_{\theta JC}}$ and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300µs pulses, duty cycle 0.5% max. F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(MAX)}$ =175° C. The SOA curve provides a single pulse rating.

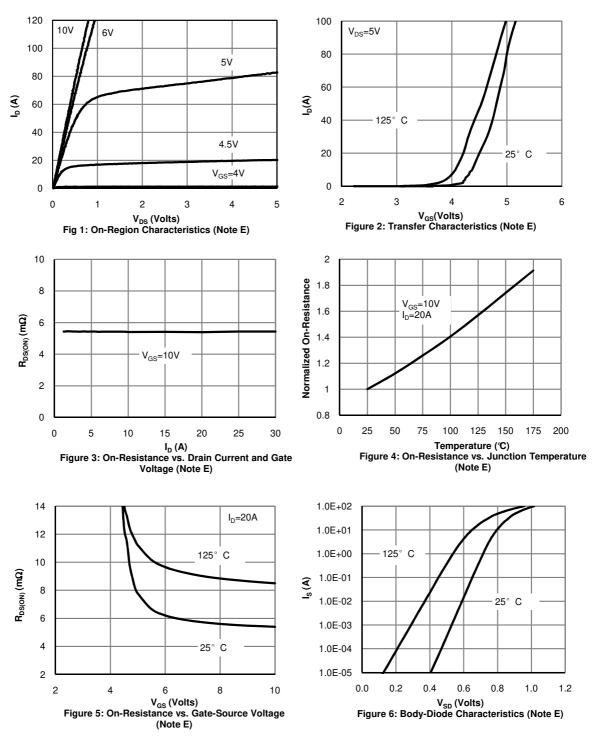
G. The maximum current rating is package limited.

H. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25° C.

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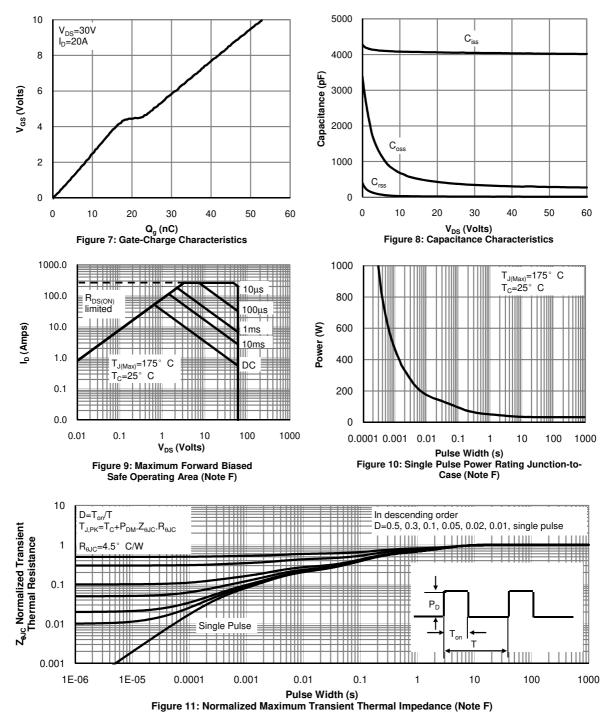


TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS





TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

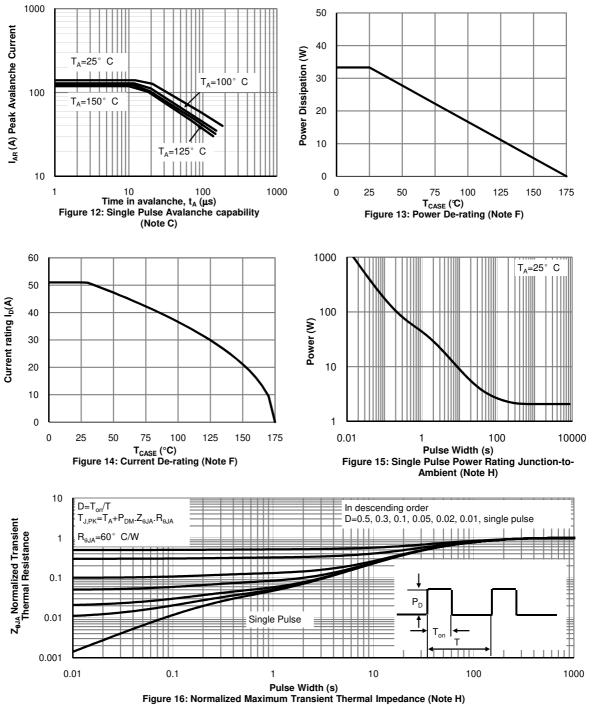


TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

ALPHA & OMEGA

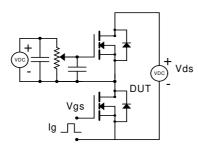
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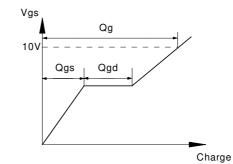
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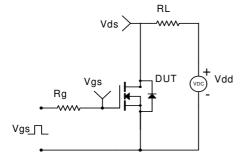


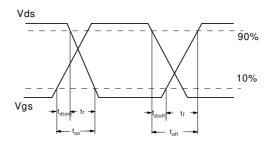
Gate Charge Test Circuit & Waveform



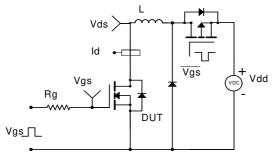


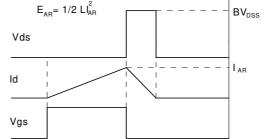
Resistive Switching Test Circuit & Waveforms





Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms

